


<b>Search Notes</b>  	<b>Application/Control No.</b>  10039845	<b>Applicant(s)/Patent Under Reexamination</b>  BEN-HAIM ET AL.
	<b>Examiner</b>  Layno, Carl H	<b>Art Unit</b>  3766

SEARCHED			
Class	Subclass	Date	Examiner
600	373, 374, 377, 508, 509	9/9/08	F. Oropeza
607	4, 5, 7, 9, 11, 116, 119, 122, 123	9/9/08	F. Oropeza

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT, USPGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB, FPRS). Text search. See Search History printout for details.	7/13/07-7/15/07	CHL
See search logic printout	9/8/08	F. Oropeza
See search logic printout	9/9/08	F. Oropeza
Updated 9/8/08 and 9/9/08 search. See search logic printout	5/26/09	F. Oropeza
Updated 9/8/08 and 9/9/08 search. See search logic printout.	1/30/10	F. Oropeza
Updated 9/8/08 and 9/9/08 search. See search logic printout.	9/29/10	F. Oropeza

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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